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Technical Compliance

No. ACS-E18273

The following product has been tested by us with the listed standards and found in compliance with the council EMC directive 2014/30/EU. It is demonstrative for the compliance with this EMC Directive.

Applicant : TPV Electronics (FuJian) Co., Ltd.
Rongqiao Economic and Technological Development Zone,
Fuqing City, Fujian Province, P.R. China

Product : LCD Monitor

Model No. : 241B8Q

Serial No. : 241B8Q; 241B8QJEB; 241B8Q*****
(* = A-Z, a-z, 0-9, hyphen, \ or blank)

Brand : PHILIPS

Test Standards :	
EN 55032: 2012+AC: 2013 (Class B) EN 55032: 2015 EN 55032: 2015+AC: 2016 CISPR 32: 2012 CISPR 32: 2015+COR1: 2016 AS/NZS CISPR 32:2015	Electromagnetic compatibility of multimedia equipment - Emission requirements
EN 61000-3-2: 2014	Electromagnetic compatibility(EMC) Part 3-2:Limits-Limits for harmonic current emissions(equipment input current $\leq 16A$ per phase)
EN 61000-3-3: 2013	Electromagnetic compatibility(EMC) Part 3-3:Limits-Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current $\leq 16A$ per phase and not subject to conditional connection
EN 55024: 2010 EN 55024: 2010+A1:2015	Information technology equipment-Immunity characteristics limits and methods of measurement
	IEC 61000-4-2: 2008 Electrostatic Discharge
	IEC 61000-4-3: 2010 RF Field Strength Susceptibility
	IEC 61000-4-4: 2012 Electrical Fast Transients
	IEC 61000-4-5: 2014 Surge
	IEC 61000-4-6: 2013 Conducted Susceptibility
	IEC 61000-4-8: 2009 Magnetic Field Immunity
	IEC 61000-4-11: 2004 IEC 61000-4-11:2004+A1: 2017 Dips / Voltage Interruption Variation

Stamp only for EMC Dept. Report

Signature: David Jin

David Jin

Manager

Date : Aug.24, 2018

The technical compliance is based on a single evaluation of one sample of above mentioned product. It does not imply an assessment of the whole production and does not permit the use of the test lab. logo.